



ATHENA Silicon Tracker Material Scan (DD4HEP)

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Baseline Design Details at <u>https://wiki.bnl.gov/athena/index.php/Tracking</u>

- Silicon pixel: 10x10x40 um
- 3 groups of barrel layers:
 - 2 vertex layers (ITS3, 0.05% X0 / layer) + 0.3mm carbon fiber support shell
 - 2 inner barrel layers and 2 outer barrel layers (staves, 0.55% X0 /layer = silicon + aluminum + triangular carbon fiber frame)
- 5 disks on each side:
 - ITS3, 0.24% / disk = silicon + aluminum
- 2mm carbon fiber support frame along cone and outer barrel/disks (thick orange line)
- Service material (X/X0 = 0.022) along the cone and endcap outer support shell



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Already Implemented (as of Aug 23)





Outermost three disks and the support frame



- Stave tilt angle 5 degree
- Number of staves optimized for full coverage
- 12 panels per Disk, to be optimized

Updates in Progress	 To do: 2mm carbon shell around the outer barrel Disk-like connection b/w the end of vertex layer and the con flush the cone
Dashed line: staves from ITS2 design Disks made of 12 panels	

Material Scan

Based on TGeometry DD4hep command line utility: materialScan Code: run_matscan.sh (to be added in benchmark)





Service Material

 $X0 = \frac{1}{6}$ Aluminum \Rightarrow use equivalent aluminum thickness in simulation

stave Stave transition		Stave X/X0	Stave transition (per 100 cm^2 of Si surface)*	Services (per 100 cm^2 of Si surface)*	Patch panel (per 100 cm^2 of Si surface)*
	ITS3 like vertexing	~0.1%	6.66 cm^3 of material with X/X0 of 0.0684 per traversed cm	2.96 cm ² cross section with X/X0 of 0.022 per traversed cm	4.32 cm x 1cm x 1 cm with 0.102 X/X0 per traversed cm
S E V I C E S	ITS3 like barrel (up to 1.5m length)	0.55 %	4.286 cm ³ of material with X/X0 of 0.0684 per traversed cm	1.905 cm ² cross section with X/X0 of 0.022 per traversed cm	2.778cm x 1cm x 1 cm with 0.102 X/X0 per traversed cm
	ITS3 like disc (up to 60 cm diameter)	0.24%	6.66 cm ³ of material with X/X0 of 0.0684 per traversed cm	2.96 cm ² cross section with X/X0 of 0.022 per traversed cm	4.321 cm x 1cm x 1 cm with 0.102 X/X0 per traversed cm
h panel				* Cc	orrected 2021_03_13

Summary of ITS3 like Si tracking

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